

Infineon

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A Simple Model Extension for Reverse Recovery Effect in Spectre Syntax

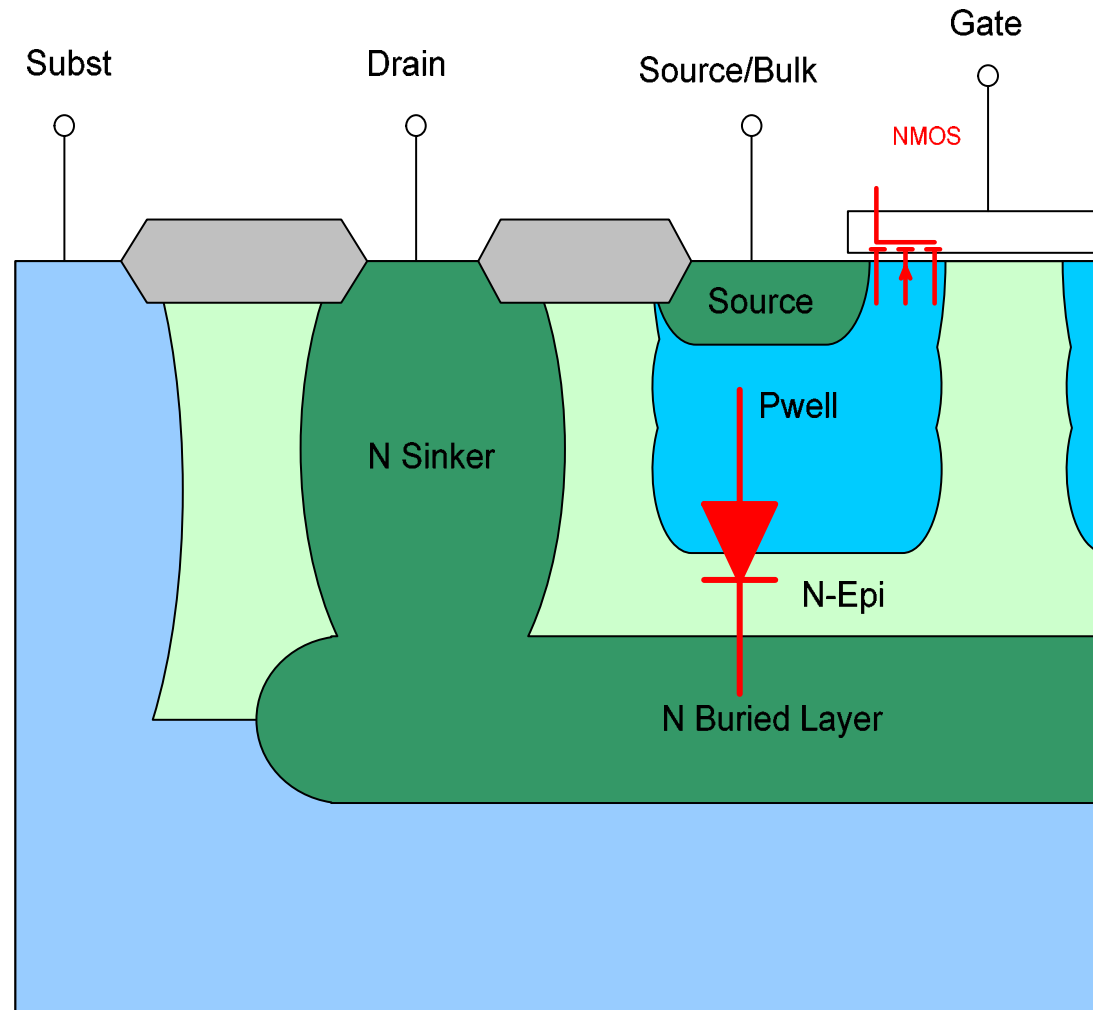


Never stop thinking.

Motivation

- Reverse Recovery Behavior is important in Some Smart Power Circuits
- No Measurements are available
- Charge Carrier Lifetime known from literature
 $\tau = 1.0 \times 10^{-7}$, if $N > 5.0 \times 10^{16} \text{ cm}^{-3}$
- A Model extension is needed for Diodes and DMOS Transistors

Device Example DMOS



Equations

Charge Control Continuity Equation

$$I_{tot} = \frac{dq}{dt} + \frac{q}{Tau} \quad (1)$$

Charge Storage

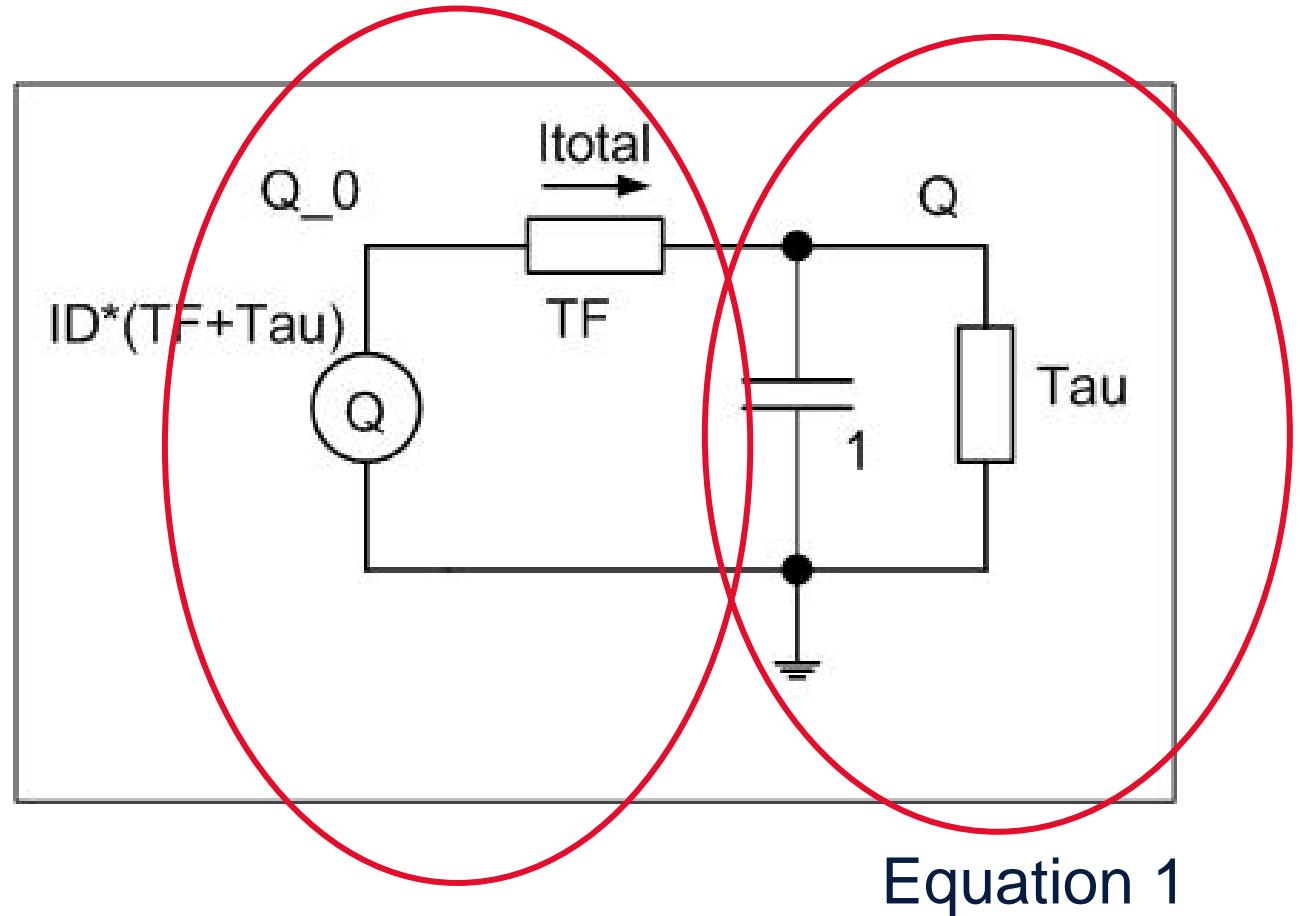
Recombination

$$I_{tot} - I_D = \frac{q_0 - q}{T_F} \quad (2)$$

$$q_0 = Tau \cdot I_D \quad (3)$$

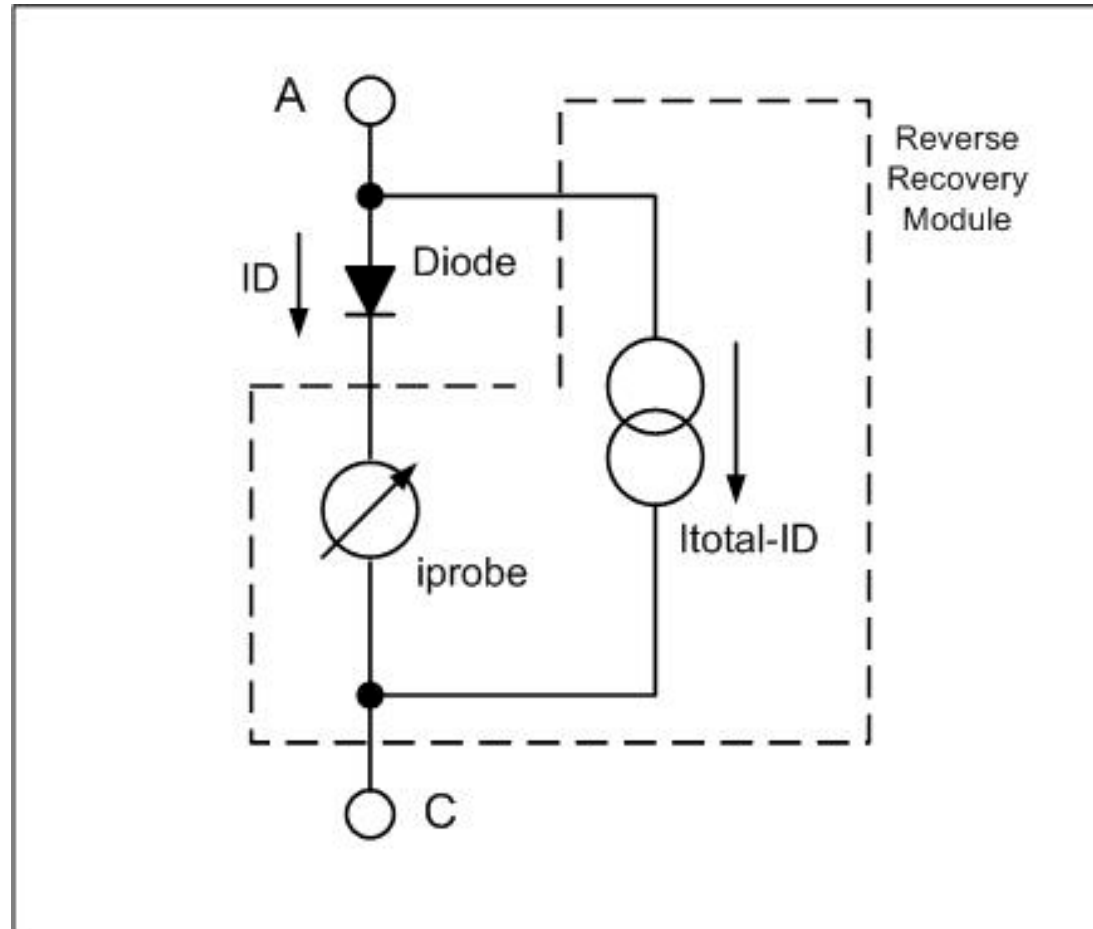
I_{tot} : total current I_D : Diode current T_F : Transit Time
 q_0 : charge in equilibrium state

Circuit 1



Equations 2 and 3

Circuit 2



I_{tot} comes from Circuit 1

Spectre Implementation

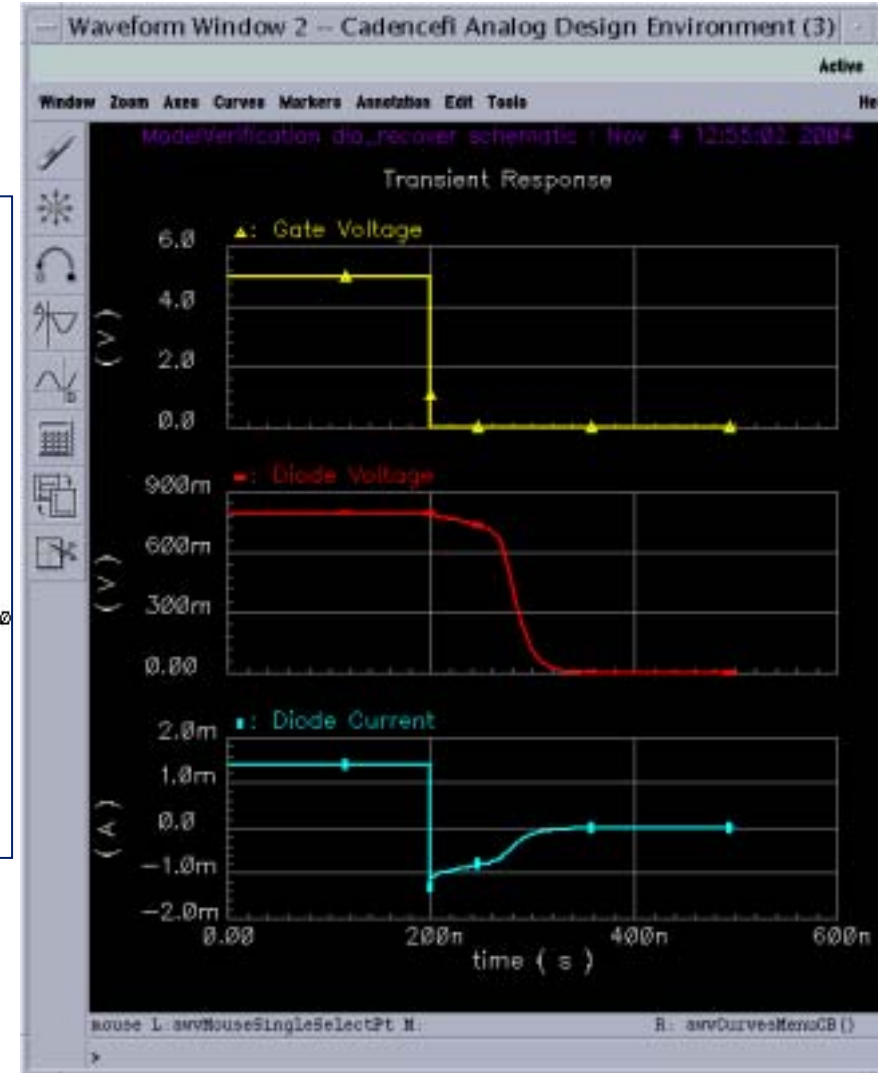
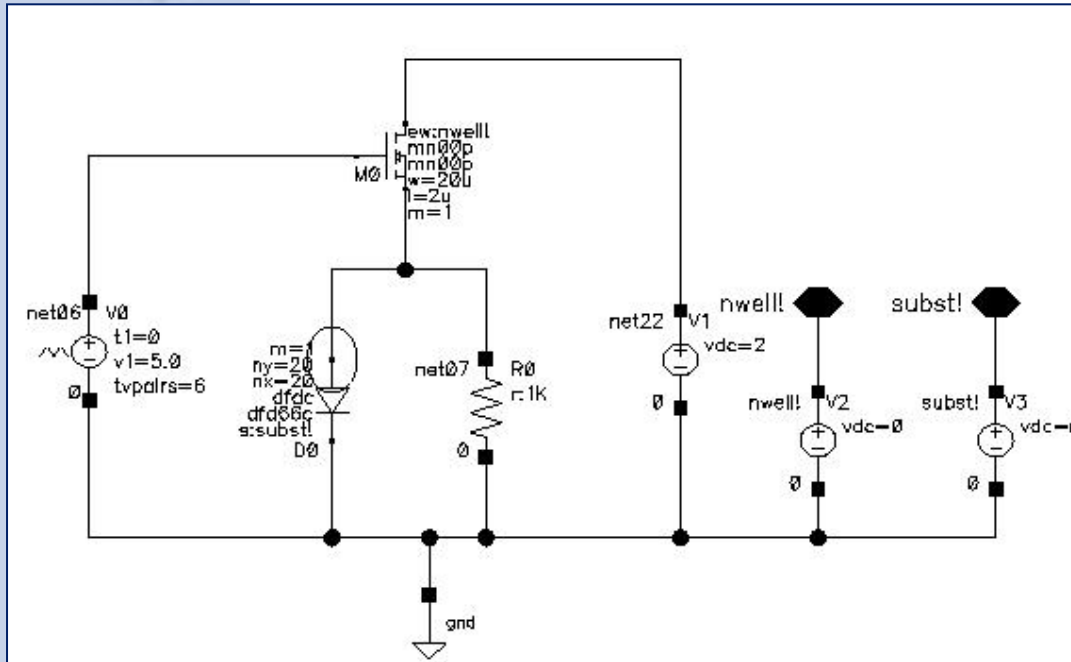
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inline subckt recoverdio (p1 p2 n)
parameters
+ tau= 1.000e-07 // carrier life time
+ tf = 1.000e-08 // transit time
+ factor=1.0e+09 // factor for better convergency, no effect on result

n1      ( tq t1 ) node value="Q" flow="I"
ip1     ( p1 p2 ) iprobe
h0      ( t1 0 ) ccvs   rm=tf+tau probe=ip1
r1      ( t1 tq ) resistor r=tf*factor
r2      ( tq 0 ) resistor r=tau*factor
recoverdio (tq 0 ) capacitor c=1.0/factor
cc1     ( p2 n ) cccs gain=factor probe=h0
cc2     ( p2 n ) cccs gain=1 probe=ip1
ends recoverdio

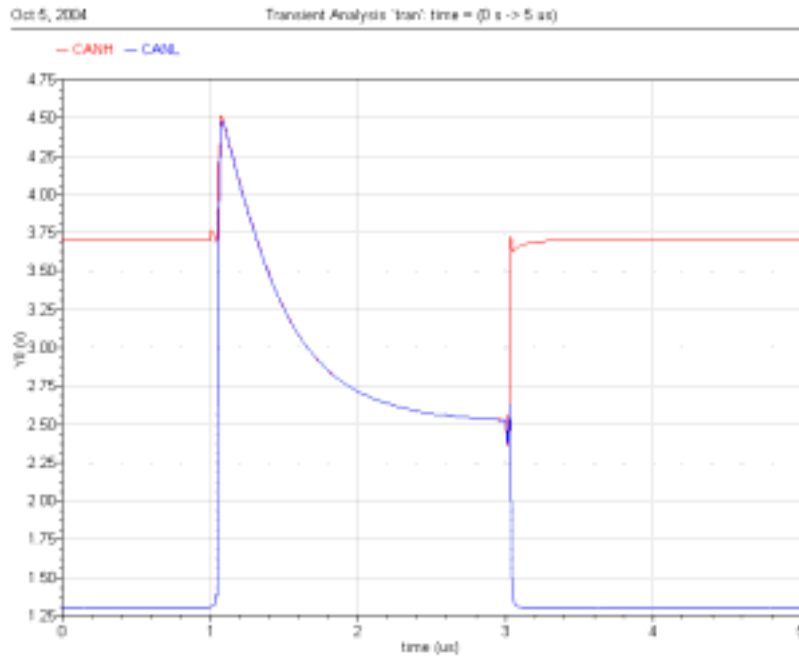
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Reverse Recovery Characteristics

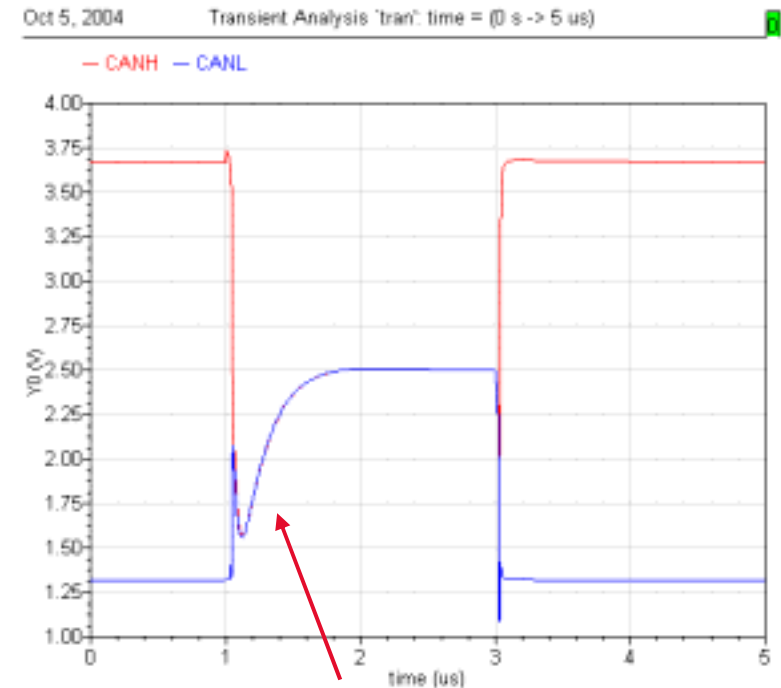


Design Example High Speed CAN (Controller Area Network, Data Bus in a car)

without Rev. Recovery Effect



with Rev. Recovery Effect



Additional dynamical measurements of diodes are necessary

Fits to Measurement

Bibliography

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Physics-Based Models of Power Semiconductor Devices
for the Circuit Simulator SPICE from R.Kraus,
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